



Used in Lieu of PTO/SB08A/B  
(Based on PTO 04-07 version)

Substitute for form 1449/PTO		<b>Complete If Known</b>	
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  <i>(Use as many sheets as necessary)</i>		Application Number	10/814,144-Conf. #7353
		Filing Date	April 1, 2004
		First Named Inventor	Mitsuaki NAKAMURA
		Art Unit	2646 2416
		Examiner Name	X. S. Wong
Sheet	1	of	1
		Attorney Docket Number	1248-0711PUS1

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (If known)			
/X.VV	AA*	US-6,480,480-B1	11-12-2002	Du	
	AB*	US-2005/0164697-A1	07-28-2005	Maeshima et al.	
	AC*	US-2005/0164689-A1	07-28-2005	Maeshima et al.	
	AD*	US-2002/0032025-A1	03-14-2002	Maeshima et al.	
	AE*	US-2004/0179488-A1	09-16-2004	Kim et al.	
/X.VV	AF*	US-2002/0055978-A1	05-09-2002	Joon-Bo et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear	†*
		Country Code <sup>2</sup> -Number-Kind Code <sup>3</sup> (If known)	MM-DD-YYYY			
/X.VV	BA	JP-2003-23434-A	01-24-2003			✓
↓ /X.VV	BB	JP-2002-111689-A	04-12-2002			
	BC	JP-11-239138-A	08-31-1999			
	BD	JP-2004-282758-A	10-07-2004			
	BE	JP-2002-223217-A	08-09-2002			

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. <sup>1</sup> CITE NO.: These application(s) which are marked with an asterisk (\*) next to the Cite No. are not supplied (under 37 CFR 1.88(e)(2)(iii)) because that application was filed after June 30, 2003 or is available in the IPW. <sup>2</sup> Applicant's unique citation designation number (optional). <sup>3</sup> See Kinds Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04. <sup>4</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>5</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>6</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>7</sup> Applicant is to place a check mark here if English language Machine Translation is attached.

NON PATENT LITERATURE DOCUMENTS					
Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			T <sup>2</sup>
_____	_____	_____			_____

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature	/Xavier S. Wong/	Date Considered	12/19/2008
--------------------	------------------	-----------------	------------

Birch, Stewart, Kolatch & Birch, LLP

CG/CMV/ta